

Search Notes

Application/Control No.

10/801,899

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

JIN ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
363	16		
	17		
	21.01		
	21.1		
	21.11		
	21.17		
	21.18		
	41		
	56.12		
	97		
	98		
	131		
	132	9/05	JA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See search report		9/05	JA

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR